100V N-Channel MOSFET

General Features

- \triangleright
- \triangleright
- Proprietary New Planar Technology $R_{DS(ON),typ}$ =30m Ω @V_{GS}=10V Low Gate Charge Minimize Switching Loss \triangleright
- Fast Recovery Body Diode \triangleright

Applications ≻ Automotive

- DC Motor Control

Ordering Information

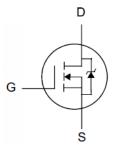
Part Number	Package	Brand
PTP540	TO-220	ľ

Absolute Maximum Ratings

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BV _{DSS}	R _{DS(ON),typ.}	I _D
100V	30mΩ	33A





 $T_C=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	PTP540	Unit
V _{DSS}	Drain-to-Source Voltage	100	V
V _{GSS}	Gate-to-Source Voltage	±20	V
I _D	Continuous Drain Current	33	٨
I _{DM}	Pulsed Drain Current at V _{GS} =10V	Figure 6	- A
E _{AS}	Single Pulse Avalanche Energy	750	mJ
D	Power Dissipation	150	W
P _D	Derating Factor above 25°C	1.0	W/℃
T_L	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300	°C
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 175	C

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	PTP540	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	1	°C AA/
R _{θJA}	Thermal Resistance, Junction-to-Ambient	62	°C/W

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Electrical Characteristics

OFF Characteristics $T_J = 25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	100			V	V_{GS} =0V, I _D =250uA
	Drain to Course Lookage Current			1		V _{DS} =100V, V _{GS} =0V
IDSS	I _{DSS} Drain-to-Source Leakage Current			100	uA	V _{DS} =80V, V _{GS} =0V, T _J =125℃
	Gate-to-Source Leakage Current			+100	n 4	V _{GS} =+20V, V _{DS} =0V
I _{GSS}	Gale-10-Source Leakage Current			-100	nA	V _{GS} =-20V, V _{DS} =0V

ON Characteristics	
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ON Chara	IN Characteristics				ງ =25 ℃ ປ	Inless otherwise specified
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
R _{DS(ON)}	Static Drain-to-Source On-Resistance		30	44	mΩ	V _{GS} =10V, I _D =17A
V _{GS(TH)}	Gate Threshold Voltage	2.0		4.0	V	V_{DS} = V_{GS} , I_D =250uA
gfs	Forward Transconductance		80		S	VDS=15V,ID=17A

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
C _{iss}	Input Capacitance		2700			V -0V
C _{rss}	Reverse Transfer Capacitance		10		pF	V _{GS} =0V, V _{DS} =25V,
C _{oss}	Output Capacitance		300			f=1.0MHz
Qg	Total Gate Charge		37			
Q_{gs}	Gate-to-Source Charge		11		nC	V _{DD} =50V, I _D =17A, V _{GS} =0 to 10V
Q _{gd}	Gate-to-Drain (Miller) Charge		8			2 / 00

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
td(ON)	Turn-on Delay Time		18			
trise	Rise Time		20		20	V _{DD} =50V, I _D =17A,
td(OFF)	Turn-Off Delay Time		53		nS	V _{GS} = 10V Rg=9.1Ω
tfall	Fall Time		7			

Source-Drain Body Diode Characteristics

 T_J =25°C unless otherwise specified

Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions
I _{SD}	Continuous Source Current ^[2]			33	^	Integral PN-diode in
I _{SM}	Pulsed Source Current ^[2]			132	A	MOSFET
V _{SD}	Diode Forward Voltage			1.5	V	I _S =33A, V _{GS} =0V
trr	Reverse recovery time		150		ns	IF=33,
Qrr	Reverse recovery charge		0.55		uC	di⊧/dt=100A/µs

Note:

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^[1] T_J =+25°C to +150°C [2] Pulse width≤380µs; duty cycle≤2%.

Typical Characteristics

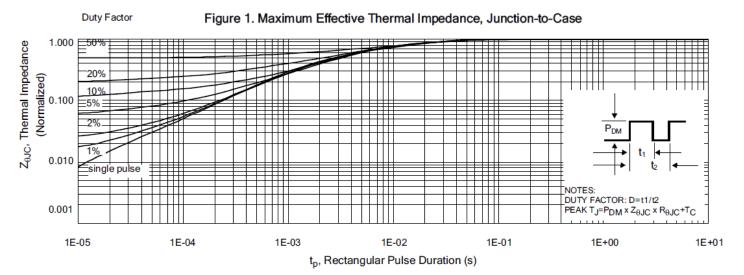
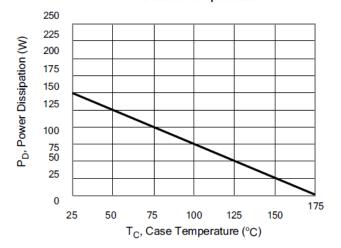


Figure 2. Maximum Power Dissipation vs Case Temperature



= 15V

 $\pm 10V$

GS

_{GS} = 9V

10

105

90

75

60

45

30

15

0

0

I_D, Drain Current (A)

Figure 4. Typical Output Characteristics

20

V_{DS}, Drain-to-Source Voltage (V)

Figure 3. Maximum Continuous Drain Current vs Case Temperature

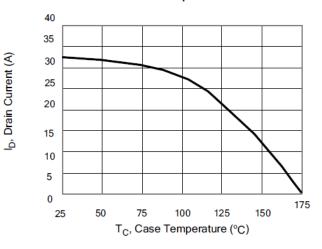
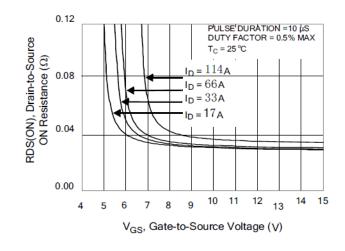
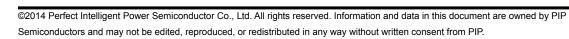


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current





PULSE DURATION = 10 µS DUTY FACTOR = 0.5% MAX

V_{GS} = 8V

V_{GS} = 7V

V_{GS} = 6V

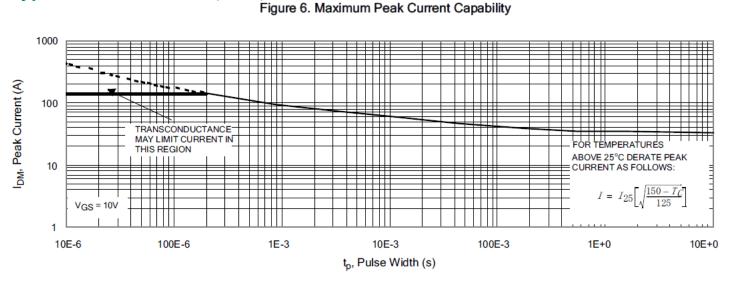
30

/GS = 5.5V /GS = 5V

40

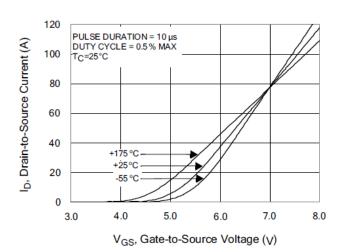
 $T_C = 25^{\circ}C$

Typical Characteristics(Cont.)



As, Avalanche Current (A)





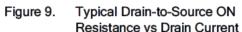


Figure 8. Unclamped Inductive Switching Capability

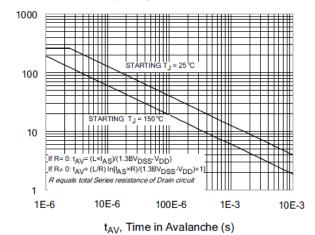
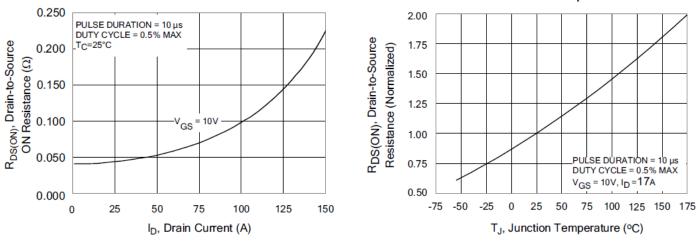
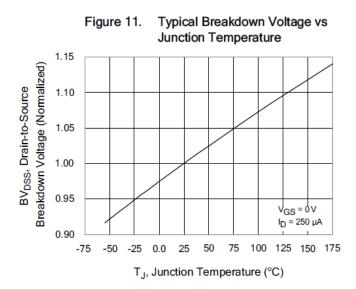


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature

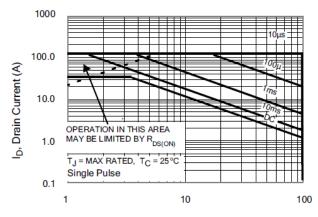


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Typical Characteristics(Cont.)

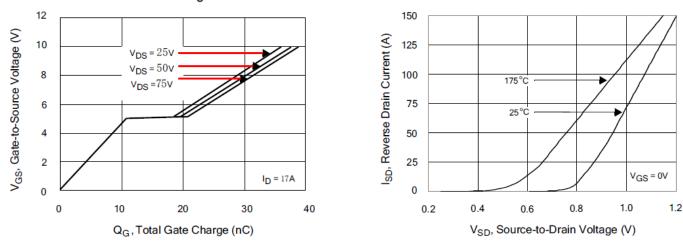






V_{DS}, Drain-to-Source Voltage (V)

Figure 15. Typical Gate Charge vs Gate-to-Source Voltage



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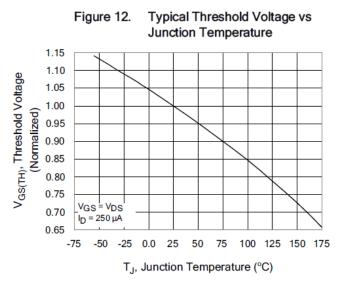


Figure 14.

Typical Capacitance vs Drain-to-Source Voltage

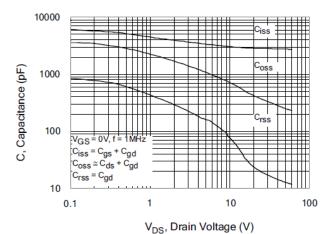


Figure 16. Typical Body Diode Transfer Characteristics

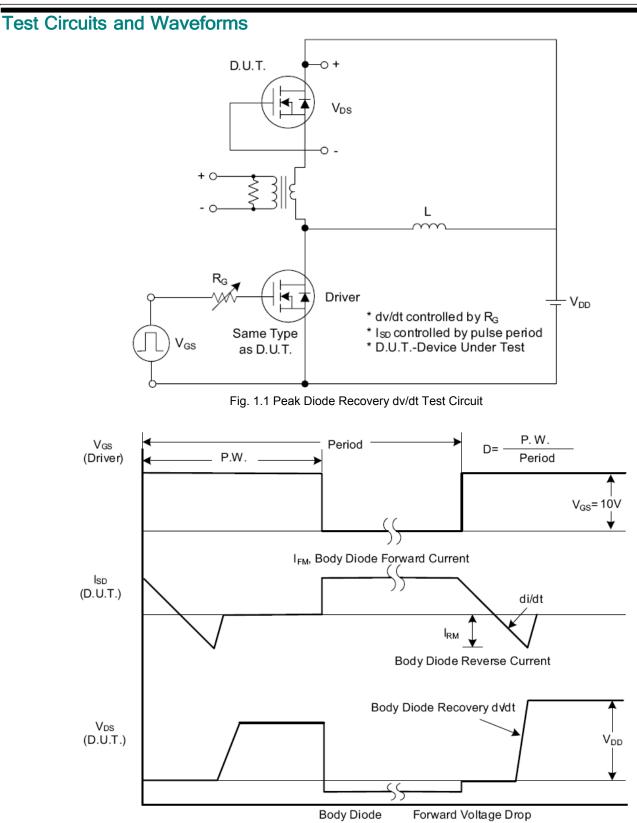
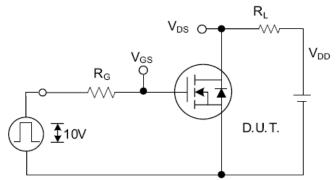


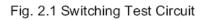
Fig. 1.2 Peak Diode Recovery dv/dt Waveforms

2

PTP540

Test Circuits and Waveforms (Cont.)





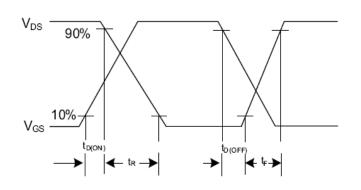


Fig. 2.2 Switching Waveforms

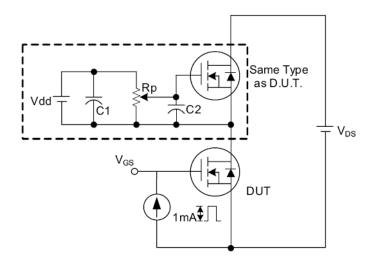


Fig. 3 . 1 Gate Charge Test Circuit

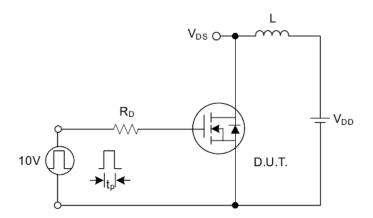
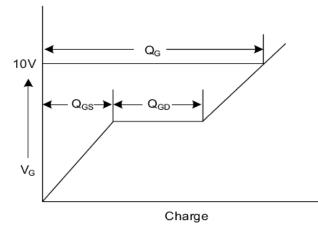
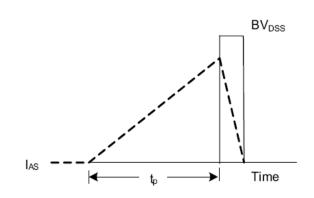
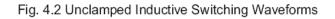


Fig. 4.1 Unclamped Inductive Switching Test Circuit









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